

<b>Notice of References Cited</b>	Application/Control No. 10/618,038	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0077193	04-2006	Thielemans et al.	345/204
*	B	US-2005/0259117	11-2005	Rackham, Guy Jonathan James	345/619
*	C	US-2003/0152148	08-2003	Laksono, Indra	375/240.24
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	K	US-			
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**NON-PATENT DOCUMENTS**

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